


<b>Search Notes</b> 	<b>Application/Control No.</b> 10565394	<b>Applicant(s)/Patent Under Reexamination</b> KOBAYASHI ET AL.
	<b>Examiner</b> Hau V Phan	<b>Art Unit</b> 3618

SEARCHED			
Class	Subclass	Date	Examiner
180	89.2, 309, 296, 219	11/18/08	HP
181	250, 207, 273, 227	11/18/08	HP
60	322, 299	11/18/08	HP

SEARCH NOTES			
Search Notes		Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Hau V Phan/ Primary Examiner.Art Unit 3618
--	--